

Application No.	Applicant(s)
10/679,726	HAASE ET AL.
Examiner	Art Unit
Hochem Forreith	2197

SEARCHED					
Class	Subclass	Date	Examiner		
711	103,112,1 14- 115,161- 162	9/26/2005	HF		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
PALM Inventor Search	9/22/2005	HF
Nasser Moazzami	9/30/2005	HF
Christian Chace	9/30/2005	HF
Key words: (delta or differen\$3) near2 map	9/27/2005	HF
(restor\$3 or recover\$3) same "bit map"	9/28/2005	HF